

FMOS007N03

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FMOS007N03

720mA 30V N-Channel Enhancement Mode MOSFET

Features

- $V_{DS} = 30V, I_D = 720mA$.
- $R_{DS(ON)} < 400m\Omega @ -V_{GS}=4.5V, I_D=0.5A$.
- $R_{DS(ON)} < 600m\Omega @ -V_{GS}=2.5V, I_D=0.3A$.
- Fast switching speed.
- Excellent $R_{DS(ON)}$ and low gate charge.
- Reliable and rugged.
- RoHS compliant & Halogen - Free.
- Suffix "-H" indicates Halogen-free part, ex.FMOS007N03-H.

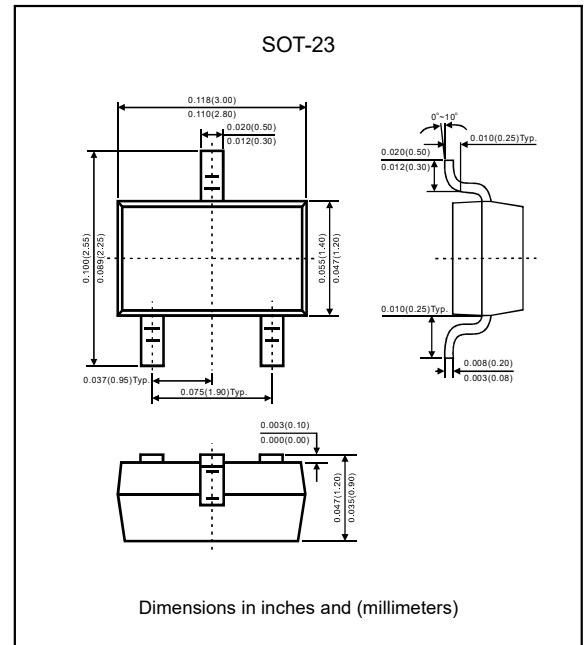
Applications

- Portable equipment.
- Battery powered system.

Mechanical data

- Epoxy:UL94-V0 rated flame retardant
- Case : Molded plastic, SOT-23
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026
- Mounting Position : Any
- Weight : Approximated 0.008 gram

Package outline



Maximum ratings ($T_A=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Ratings	Unit
Drain-source voltage	V_{DS}	30	V
Gate-source voltage	V_{GS}	± 12	V
Continuous drain current ($T_A=25^{\circ}C$)	I_D	720	mA
($T_A=70^{\circ}C$)		570	
Avalanche current, single pulse (Note 2) (L=0.1mH)	I_{AS}	1.8	A
Avalanche energy, single pulse (Note 2) (L=0.1mH)	E_{AS}	0.16	mJ
Power dissipation ($T_A=25^{\circ}C$)	P_D	360	mW
Thermal resistance form junction to ambient	$R_{\theta JA}$	350	$^{\circ}C/W$
Operating Junction temperature range	T_J	+150	$^{\circ}C$
Storage temperature range	T_{STG}	-55 to +150	$^{\circ}C$

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Electrical characteristics (At $T_j=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Off characteristics						
Drain-source breakdown voltage	BV_{DSS}	$I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$	30			V
Drain-source leakage current	I_{DSS}	$V_{DS}=24\text{V}$, $V_{GS}=0\text{V}$			1	μA
Gate-source leakage current	I_{GSS}	$V_{GS}=\pm 12\text{V}$, $V_{DS}=0\text{V}$			100	nA
On characteristics						
Gate threshold voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$	0.6	0.85	1.1	V
Forward transconductance	g_{FS}	$V_{DS}=5\text{V}$, $I_D=250\text{mA}$		5.7		S
Static drain-source on-resistance (Note 4)	$R_{DS(ON)}$	$V_{GS}=4.5\text{V}$, $I_D=500\text{mA}$		330	400	m Ω
		$V_{GS}=2.5\text{V}$, $I_D=300\text{mA}$		350	600	
		$V_{GS}=1.8\text{V}$, $I_D=100\text{mA}$		600	825	
Dynamic Parameters (Note 5)						
Gate resistance	R_G	$V_{GS}=0\text{V}$, $V_{DS}=0\text{V}$, $f=1.0\text{MHz}$		195		Ω
Input capacitance	C_{iss}	$V_{GS}=0\text{V}$, $V_{DS}=15\text{V}$, $f=1.0\text{MHz}$		38.2		pF
Output capacitance	C_{oss}			4.8		
Reverse transfer capacitance	C_{rss}			3.3		
Switching parameters						
Total gate charge	Q_g	$V_{GS}=4.5\text{V}$, $V_{DS}=15\text{V}$, $I_D=1\text{A}$		0.86		nC
Gate to source charge	Q_{gs}			0.29		
Gate to Drain charge	Q_{gd}			0.16		
Turn-on delay time	$t_{d(on)}$	$V_{DS}=15\text{V}$, $V_{GS}=4.5\text{V}$, $I_D=1\text{A}$, $R_G=6\Omega$		5.4		ns
Rise time	t_r			20.2		
Turn-off delay time	$t_{d(off)}$			34.4		
Fall time	t_f			30.3		
Source-drain diode ratings and characteristics						
Reverse recovery time	t_{rr}	$I_F=0.25\text{A}$, $V_R=20\text{V}$, $dI_F/dt=100\text{A}/\mu\text{s}$		24.2		ns
Reverse recovery charge	Q_{rr}			3.2		nC
Drain - source diode forward voltage	V_{SD}	$V_{GS}=0\text{V}$, $I_{SD}=250\text{mA}$		0.9	1.1	V

Note : 1. Max. Current is limited by junction temperature.

2. UIS tested and pulse width are limited by maximum junction temperature 150°C .

3. Surface mounted on 1 in^2 FR4 board with 1oz.

4. Pulse test (Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$).

5. Guaranteed by design, not subject to production testing.

Rating and characteristic curves (FMOS007N03)

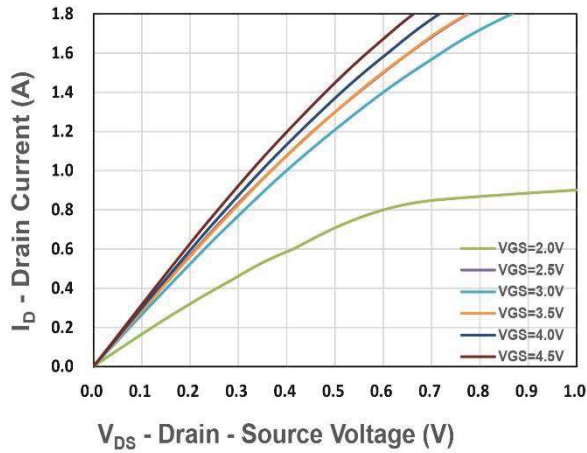


Figure 1. Output Characteristics

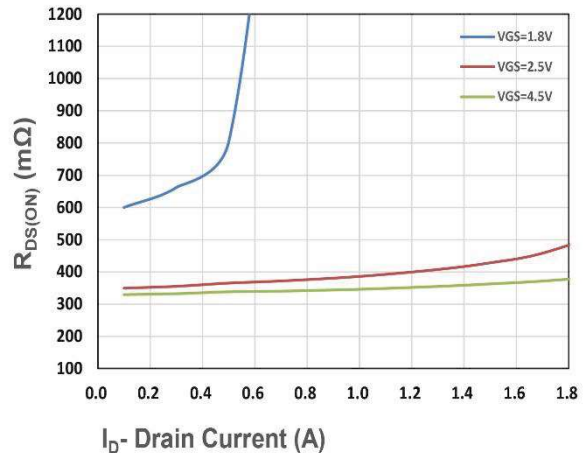


Figure 2. On-Resistance vs. ID

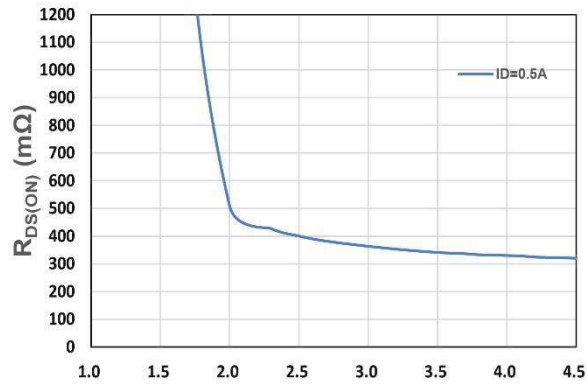


Figure 3. On-Resistance vs. VGS

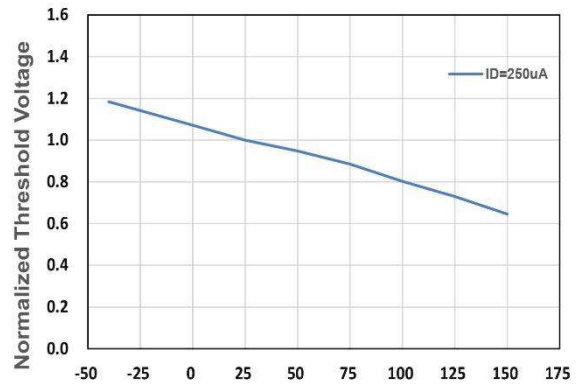


Figure 4. Gate Threshold Voltage

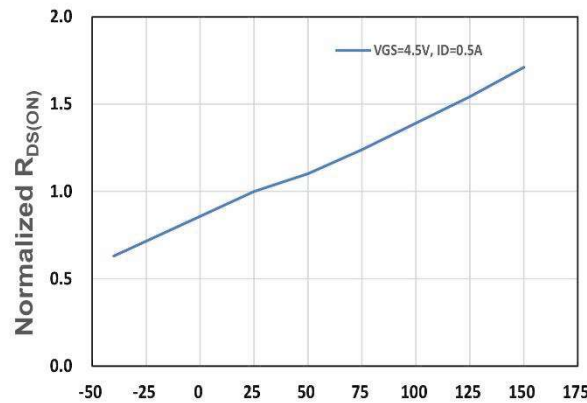


Figure 5. Drain-Source On Resistance

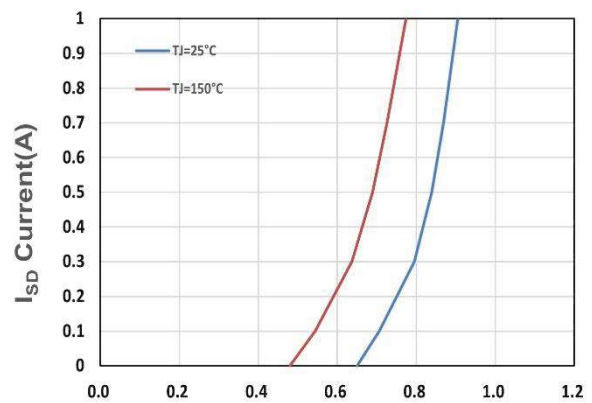
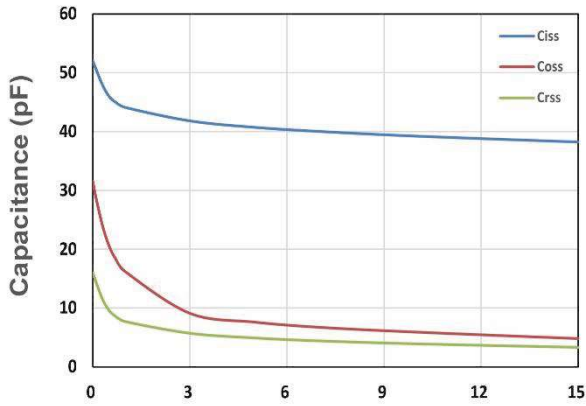


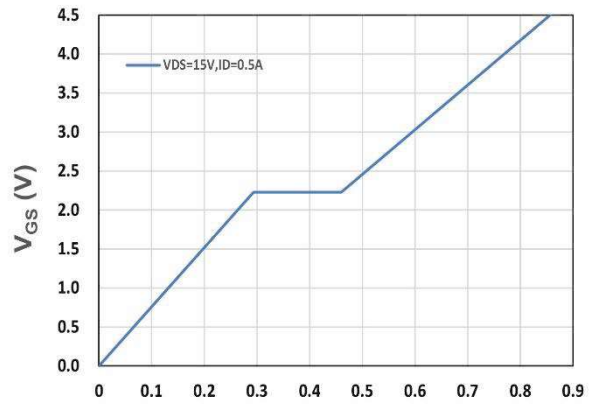
Figure 6. Source-Drain Diode Forward

Rating and characteristic curves (FMOS007N03)



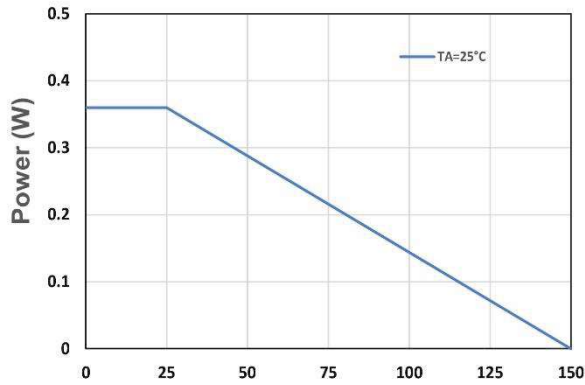
V_{DS} - Drain - Source Voltage (V)

Figure 7. Capacitance



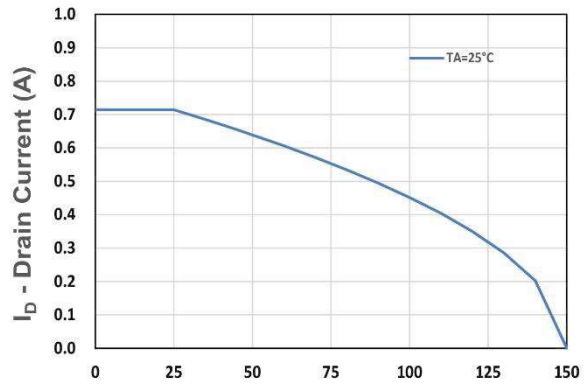
Q_g , Total Gate Charge (nC)

Figure 8. Gate Charge Characteristics



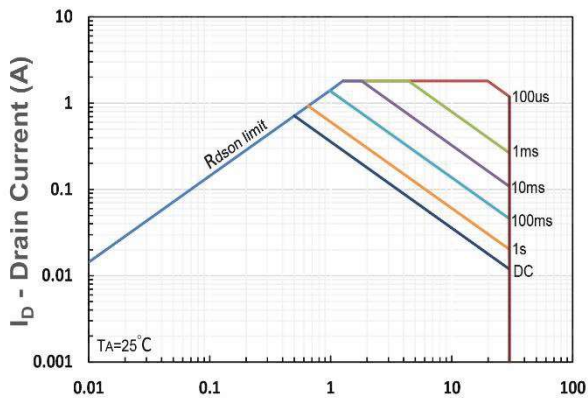
T_A - Junction Temperature (°C)

Figure 9. Power Dissipation



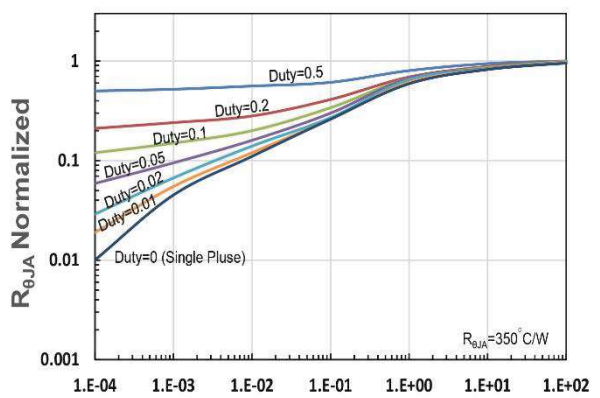
T_A - Junction Temperature (°C)

Figure 10. Drain Current



V_{DS} - Drain-Source Voltage (V)

Figure 11. Safe Operating Area

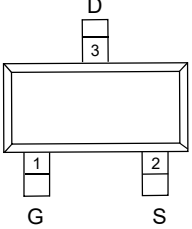
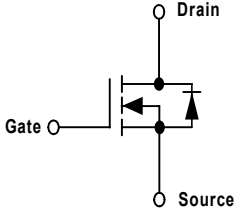


t_j , Square Wave Pulse Duration(s)

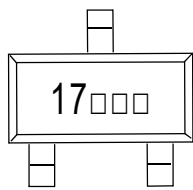
Figure 12. $R_{\theta JA}$ Transient Thermal Impedance

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Pinning information

Pin	Simplified outline	Symbol
Pin1 Gate Pin2 Source Pin3 Drain		

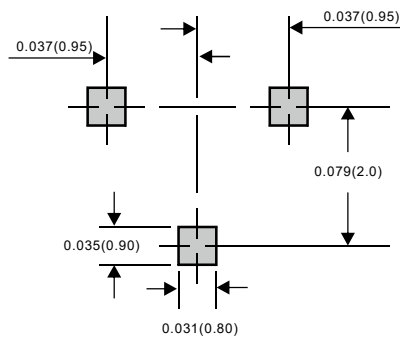
Marking



□□□ : Date Code

Suggested solder pad layout

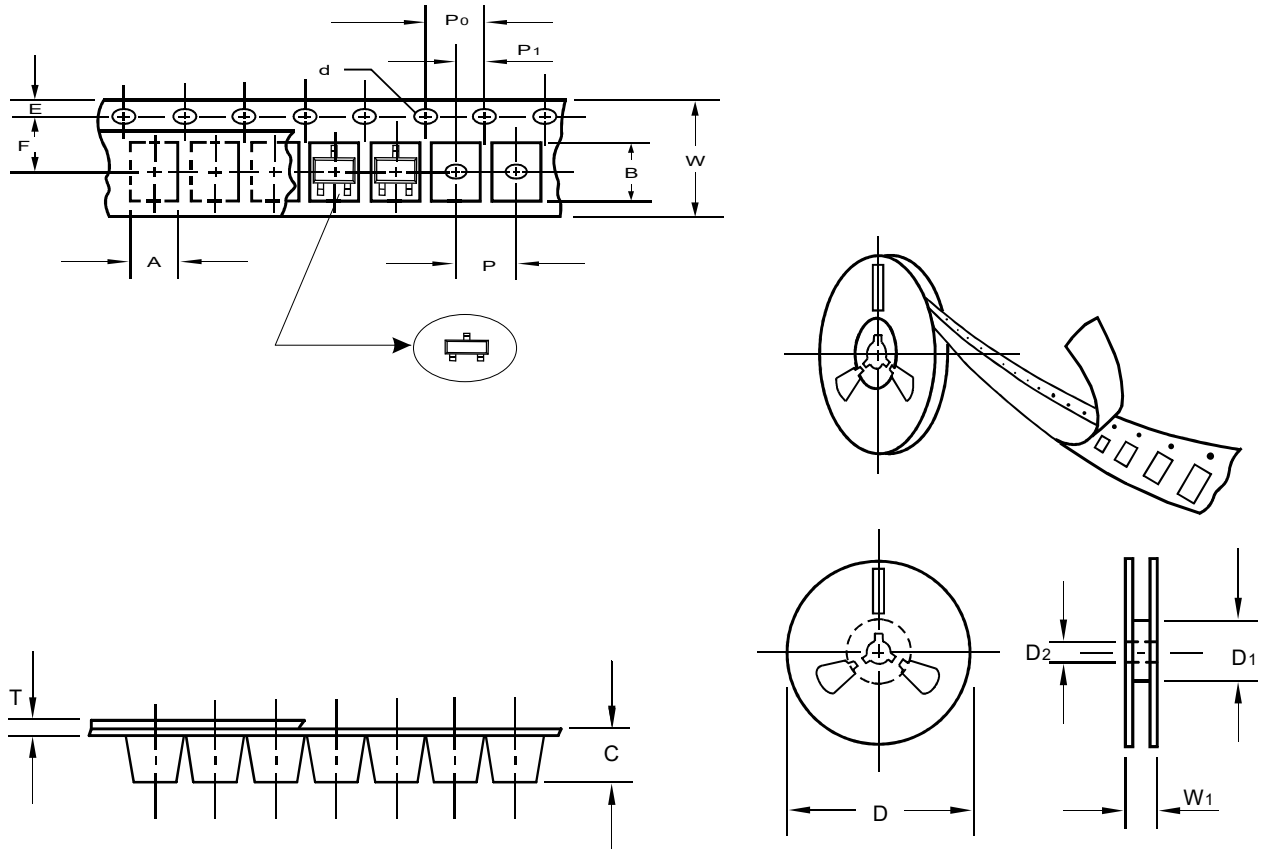
SOT-23



Dimensions in inches and (millimeters)

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Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.1	3.15
Carrier length	B	0.1	2.77
Carrier depth	C	0.1	1.22
Sprocket hole	d	0.1	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	54.40
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W1	1.0	11.40

Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

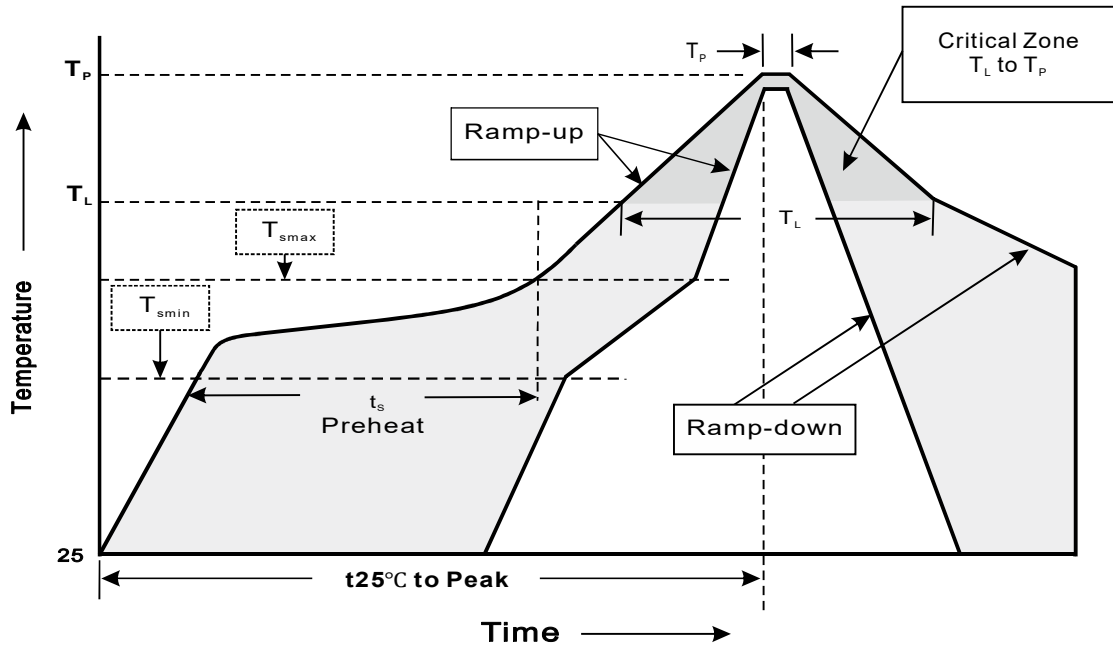
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Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)	APPROX. GROSS WEIGHT (kg)
SOT-23	7"	3,000	4.0	30,000	183*123*183	178	382*257*387	240,000	11.6

Suggested thermal profiles for soldering processes

- 1.Storage environment: Temperature=5°C~40°C Humidity=55%±25%
- 2.Reflow soldering of surface-mount devices



3.Reflow soldering

Profile feature	Soldering Condition
Average ramp-up rate (T_L to T_P)	< 3°C/sec
Preheat -Temperature Min (T_{smin}) -Temperature Max (T_{smax}) -Time (min to max) (t_s)	150°C 200°C 60 ~ 120sec
T_{smax} to T_L -Ramp-up rate	< 3°C/sec
Time maintained above: -Temperature (T_L) -Time(T_L)	217°C 60 ~ 260 sec
Peak Temperature(T_P)	255°C -0/+5°C
Time within 5°C of actual peak Temperature(T_P)	10 ~ 30sec
Ramp-down rate	< 6°C/sec
Time 25°C to peak temperature	< 6 minutes